



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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March 15, 2004


SECOND INFORMATION DISCLOSURE STATEMENT

It is respectfully requested that the above information be considered by the Examiner and that a copy of the enclosed Form PTO-1449 be returned indicating that such information has been considered.

Since no Office Action has been issued in the subject application, it is Applicant's understanding that no fee is due in connection with this Information Disclosure Statement. However, if such a fee is deemed necessary, the Commissioner is authorized to charge it to Deposit Account 06-1205.

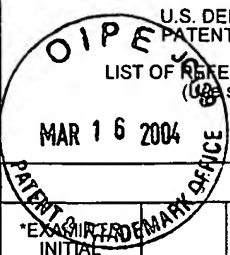
Applicant's undersigned attorney may be reached in our New York office by telephone at (212) 218-2100. All correspondence should continue to be directed to our address given below.

Respectfully submitted,



Attorney for Applicant
Registration No. 48,512

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FORM PTO 1449 (modified)		ATTY DOCKET NO. 03500.17520		APPLICATION NO. 10/647,275		
 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)		APPLICANT Hideo Ukuda				
		FILING DATE August 26, 2003		GROUP 2873		
U.S. PATENT DOCUMENTS						
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
FOREIGN PATENT DOCUMENTS						
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	TRANSLATION YES/NO/ OR ABSTRACT
	EP	1 065 531 A2	01/03/01	Europe		
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)						
		Ivan D. Nikolov et al., "Optical Plastic Refractive Measurements in the Visible and Near-Infrared Regions," 39(13) Applied Optics 2067-70 (May 2000).				
EXAMINER			DATE CONSIDERED			

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.